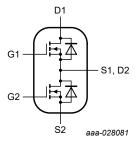
9 May 2023

Product data sheet

1. General description

Dual, logic level N-channel MOSFET in an LFPAK56D package (half-bridge configuration), using Trench 9 TrenchMOS technology. This product has been designed and qualified to AEC-Q101.

An internal connection is made between the source (S1) of the highside FET to the drain (D2) of the low-side FET, making the device ideal to use as a half-bridge switch in high-performance automotive PWM applications.



2. Features and benefits

- LFPAK56D package with half-bridge configuration enables:
 - Reduced PCB layout complexity
 - PCB shrinkage through reduced component footprint for 3-phase motor drive
 - Improved system level R_{th(j-amb)} due to optimized package design
 - Lower parasitic inductance to support higher efficiency
 - · Footprint compatibility with LFPAK56D Dual package
- Advanced AEC-Q101 grade Trench 9 silicon technology:
 - · Low power losses, high power density
 - · Superior avalanche performance
 - · Repetitive avalanche rated
- LFPAK copper clip packaging provides high robustness and reliability
- Gull wing leads support high manufacturability and Automated Optical Inspection (AOI)

3. Applications

- 12 V automotive systems
- · Powertrain, chassis, body and infotainment applications
- Brushless or brushed DC motor drive
- DC-to-DC systems
- LED lighting

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Limiting values	Limiting values FET1 and FET2						
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	40	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	42	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	46	W



Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Static chara	Static characteristics FET1 and FET2							
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 10 A; T _j = 25 °C; Fig. 11		7.9	11.35	13.6	mΩ	
Dynamic ch	Dynamic characteristics FET1 and FET2							
Q_{GD}	gate-drain charge	I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	2.1	4.2	nC	
Source-drain diode FET1 and FET2								
Q _r	recovered charge	I_S = 10 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C	[2]	-	16.2	-	nC	

^{[1] 42}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S2	source2	8 7 6 5	
2	G2	gate2	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	D1 I
3	S1, D2	source1, drain2		
4	G1	gate1		G1 — 🛱 🛣
5	D1	drain1		\$1, D2
6	D1	drain1		G2 LIFT
7	S1, D2	source1, drain2	1 2 3 4	
8	S1, D2	source1, drain2	LFPAK56D; Dual LFPAK (SOT1205)	S2 _{aaa-028081}

6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
		plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9V13-40H	9V1340H

^[2] includes capacitive recovery

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Limiting valu	ues FET1 and FET2		_			
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	40	V
V _{GS}	gate-source voltage	DC; T _j = 25 °C		-20	20	V
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	46	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	42	Α
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>		-	30	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; Fig. 3		-	169	Α
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-draii	n diode FET1 and FET2					
Is	source current	T _{mb} = 25 °C		-	42	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$		-	169	Α
Avalanche r	uggedness FET1 and FET2					'
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	I_D = 39.9 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; Fig. 4	[2] [3]	-	10.6	mJ
I _{AS}	non-repetitive avalanche current	V_{sup} = 40 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; R_{GS} = 50 Ω ; Fig. 4	[4]	-	39.9	А
	Current	1 (GS = 50 12, <u>1 ig. -</u>				

^{[1] 42}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.
- [4] Protected by 100% test

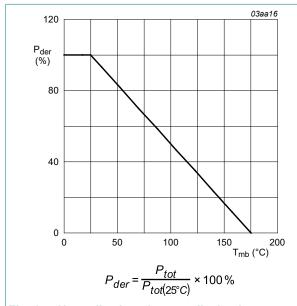
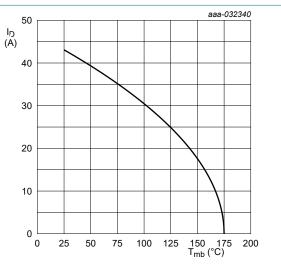


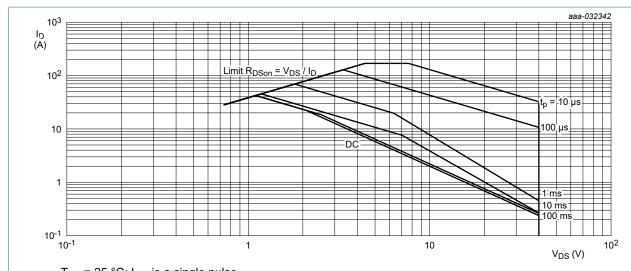
Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$ 42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

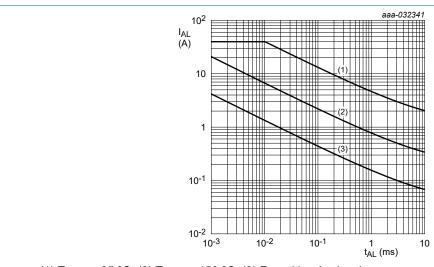
Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)



 T_{mb} = 25 °C; I_{DM} is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage, FET1 and FET2



(1) $T_{j \text{ (init)}} = 25 \text{ °C}$; (2) $T_{j \text{ (init)}} = 150 \text{ °C}$; (3) Repetitive Avalanche

Fig. 4. Avalanche rating; avalanche current as a function of avalanche time, FET1 and FET2

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 5	-	3	3.23	K/W

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

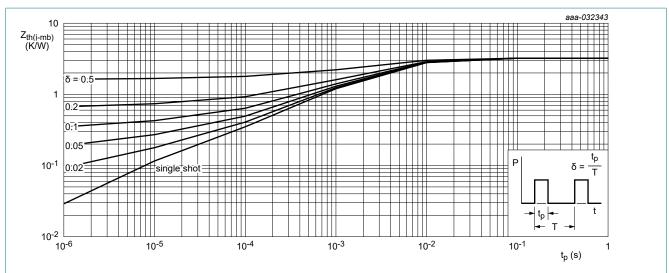


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FET2

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics FET1 and FET2					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	40	43	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	-	40.5	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	36	40	-	V
V _{GS(th)}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; <u>Fig. 9</u> ; <u>Fig. 10</u>	1.5	1.85	2.2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	0.7	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; Fig. 10$	-	-	2.6	V
I _{DSS}	drain leakage current	V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C	-	0.01	5	μΑ
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 125 °C	-	0.14	10	μA
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	26	500	μΑ
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 25 °C; Fig. 11		7.9	11.35	13.6	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 105 °C; Fig. 12		10.9	16.87	20.4	mΩ
		V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 125 °C; Fig. 12		12	18.2	21.9	mΩ
		V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 175 °C; Fig. 12		14.5	21.97	26.4	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 25 °C; Fig. 11		9.8	14.04	16.9	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 105 °C; Fig. 12		13.5	20.6	25.4	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 125 °C; Fig. 12		14.8	22.24	27.2	mΩ
		V_{GS} = 4.5 V; I_D = 10 A; T_j = 175 °C; Fig. 12		18	26.65	32.8	mΩ
R_G	gate resistance	f = 1 MHz; T _j = 25 °C		0.7	1.7	4.2	Ω
Dynamic ch	naracteristics FET1 and FE	T2	•				
Q _{G(tot)}	total gate charge	I _D = 10 A; V _{DS} = 32 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	13.9	19.4	nC
		I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V;		-	7.3	10.2	nC
Q _{GS}	gate-source charge	T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	2.5	3.8	nC
Q _{GD}	gate-drain charge			-	2.1	4.2	nC
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;		-	829	1160	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>		-	280	420	pF
C _{rss}	reverse transfer capacitance			-	38	84	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 3 \Omega; V_{GS} = 5 \text{ V};$		-	5.6	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 ^{\circ}C$		-	8.1	-	ns
t _{d(off)}	turn-off delay time	1		-	9.1	-	ns
t _f	fall time	1		-	6.5	-	ns
Source-drai	in diode FET1 and FET2		'		1	1	
V _{SD}	source-drain voltage	$I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}; Fig. 16$		-	0.84	1	V
t _{rr}	reverse recovery time	$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$		-	21.5	-	ns
Q _r	recovered charge	$V_{DS} = 20 \text{ V}; T_j = 25 \text{ °C}$	[1]	-	16.2	-	nC

^[1] includes capacitive recovery

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

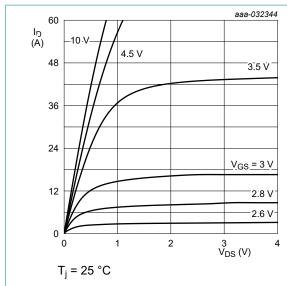


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

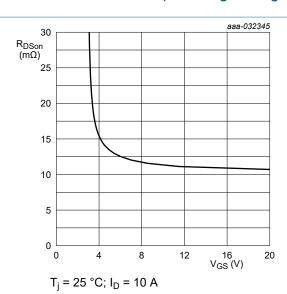


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2

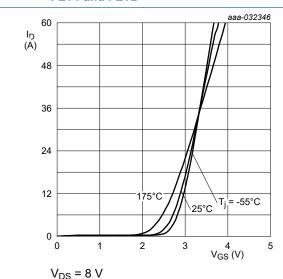


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

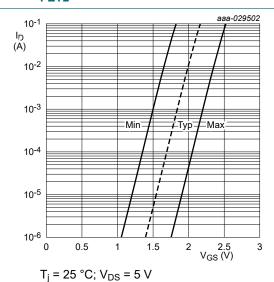


Fig. 9. Sub-threshold drain current as a function of gate-source voltage, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

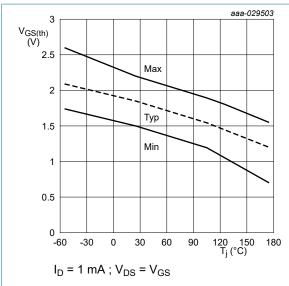


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

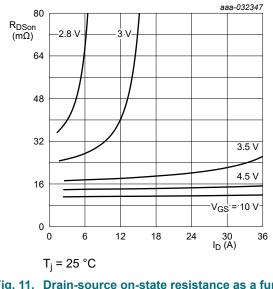


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

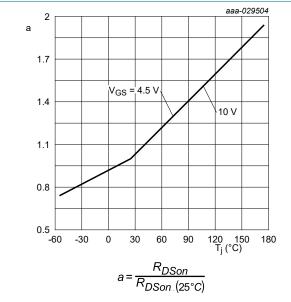


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

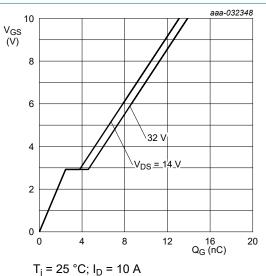


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

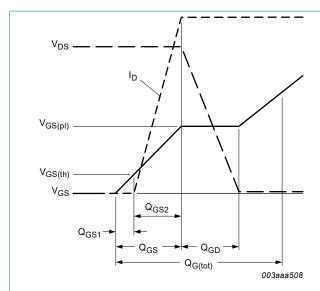
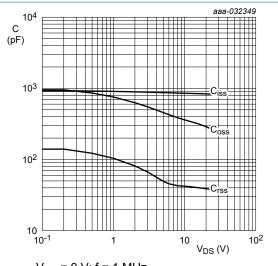


Fig. 14. Gate charge waveform definitions

 $V_{GS} = 0 V$



 $V_{GS} = 0 V$; f = 1 MHz

Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

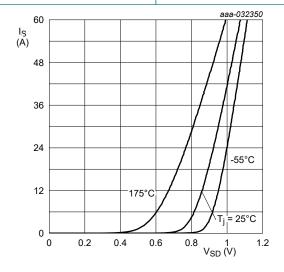
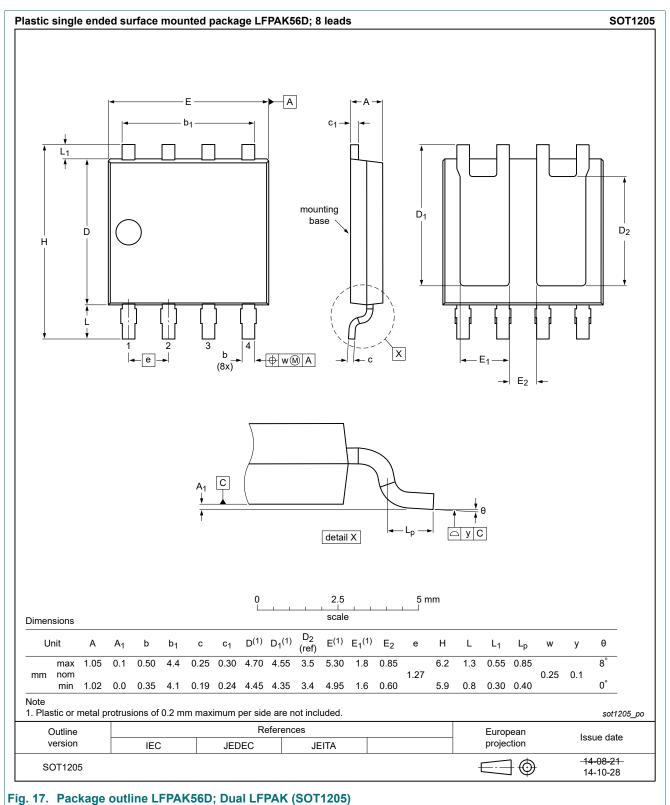


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

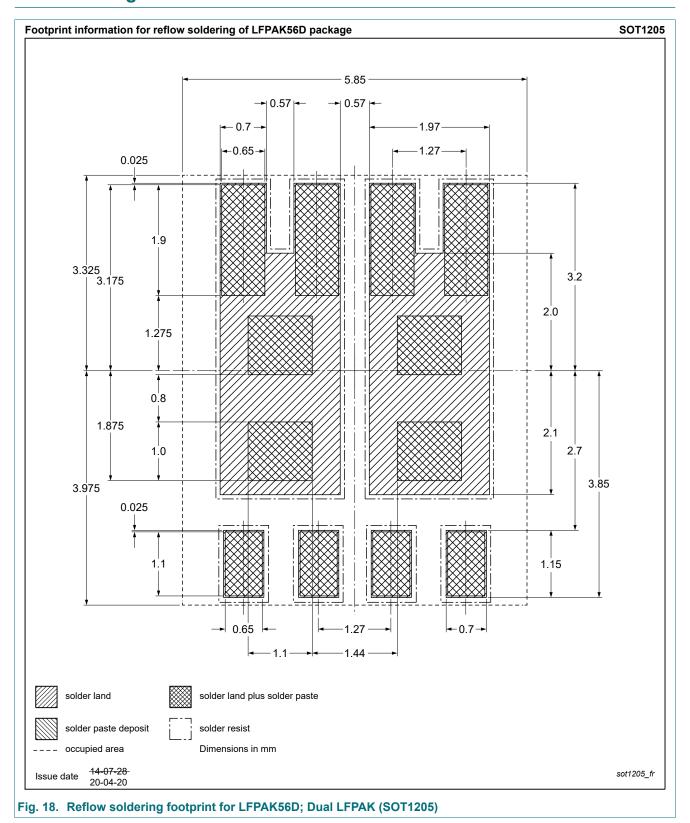
11. Package outline



Tig. 17. Tackage outline Li FARCOOD, Dual Li FAR (OOT 1200)

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

12. Soldering



13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

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